

WEST Search History

DATE: Wednesday, May 14, 2003

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DB=USPT,PGPB,JPAB,EPAB,DWPI,TDBD; PLUR=YES; OP=OR

L8	(interposer with (resilient or spring)).clm.	121	L8
L7	L6 and ((spring or resilient) with (interposer or carrier)) and (board or substrate or fixture)	56	L7
L6	((spring or resilient) with contact\$1 with (both or second or (lower and upper) or (top and bottom)) with side\$1) and semiconductor	390	L6
L5	((interposer or carrier) with (resilient or spring)) and test\$3 and semiconductor and fixture	168	L5
L4	((interposer or carrier) with spring) and test\$3 and semiconductor and fixture	146	L4
L3	(interposer with spring) and test\$3 and semiconductor and fixture	31	L3
L2	L1 and interposer	133	L2
L1	(spring with contact\$1) and (semiconductor adj (substrate or wafer))	1737	L1

END OF SEARCH HISTORY

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Terms	Documents
L6 and ((spring or resilient) with (interposer or carrier)) and (board or substrate or fixture)	56

Database:

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L7

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